Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT process)

2SC2881

Voltage Amplifier Applications Power Amplifier Applications

- High voltage: VCEO = 120 V
- High transition frequency: fT = 120 MHz (typ.)
- Small flat package
- $P_C = 1.0$ to 2.0 W (mounted on ceramic substrate)
- Complementary to 2SA1201

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-base voltage	V_{CBO}	120	V	
Collector-emitter voltage	V _{CEO}	120	٧	
Emitter-base voltage	V _{EBO}	5	V	
Collector current	IC	800	mA	
Base current	Ι _Β	160	mA	
Collector power dissipation	P _C	500	mW	
	P _C (Note 1)	1000		
Junction temperature	Tj	150	°C	
Storage temperature range	T _{stg}	−55 to 150	°C	

Note 1: Mounted on ceramic substrate (250 mm² × 0.8 t)

1.6MAX 4.6MAX 1.7MAX 0.4 ± 0.05 + 0.08 0.4 - 0.05 1.5 ± 0.1 1.5 ± 0.1 1. Base 2. Collector (heat sink) 3. Emitter PW-MINI JEDEC JEITA SC-62 TOSHIBA 2-5K1A

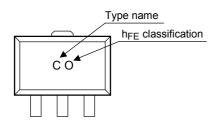
Weight: 0.05 g (typ.)

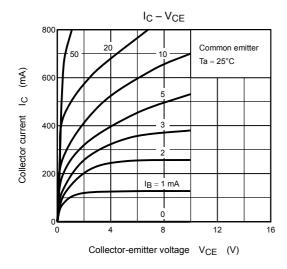
Electrical Characteristics (Ta = 25°C)

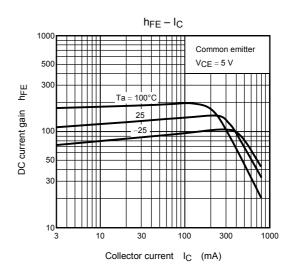
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	V _{CB} = 120 V, I _E = 0	_	_	0.1	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} = 5 V, I _C = 0	_	_	0.1	μΑ
Collector-emitter breakdown voltage	V (BR) CEO	I _C = 10 mA, I _B = 0	120	_	_	V
Emitter-base breakdown voltage	V (BR) EBO	I _E = 1 mA, I _C = 0	5	_	_	V
DC current gain	h _{FE} (Note 2)	V _{CE} = 5 V, I _C = 100 mA	80	_	240	_
Collector-emitter saturation voltage	V _{CE (sat)}	I _C = 500 mA, I _B = 50 mA	_	_	1.0	V
Base-emitter voltage	V _{BE}	V _{CE} = 5 V, I _C = 500 mA	_	_	1.0	V
Transition frequency	f _T	V _{CE} = 5 V, I _C = 100 mA	_	120	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	_	_	30	pF

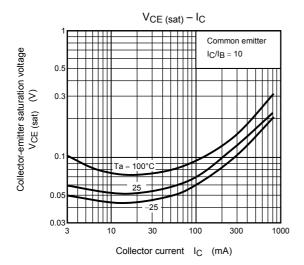
Note 2: $h_{\mbox{\scriptsize FE}}$ classification O: 80 to 160, Y: 120 to 240

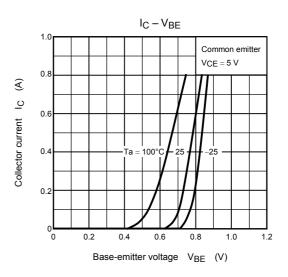
Marking

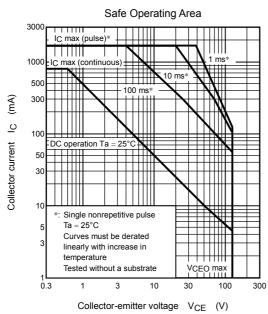


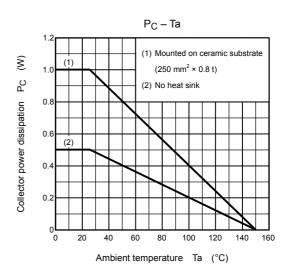












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